

To all our customers

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Renesas Technology Corp.  
Customer Support Dept.  
April 1, 2003

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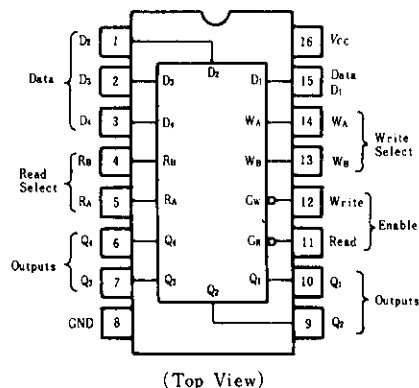
# HD74LS670 ● 4-by-4 Register File (with three-state outputs)

The HD74LS670, 16-bit register file incorporates the equivalent of 98 gates. The register file is organized as 4 words of 4 bits each and separate on-chip decoding is provided for addressing the the four word locations to either write-in or retrieve data.

This permits simultaneous writing into one location and reading from another word location. Four data inputs are available which are used to supply the 4-bit word to be stored. Location of the word is determined by the write-address inputs A and B in conjunction with a write-enable signal. Data applied at the inputs should be in its true form. That is, if a high-level signal is desired from the output, a high-level is applied at the data input for that particular bit location. The latch inputs are arranged so that new data will be accepted only if both internal address gate inputs are high. When this condition exists, data at the D input is transferred to the latch output. When the write-enable input,  $G_W$ , is high, the data inputs are inhibited and their levels can cause no change in the information stored in the internal latches. When the read-enable input,  $G_R$ , is high, the data outputs are inhibited and go into the high-impedance state. The individual address lines permit direct acquisition of data stored in any four of the latches. Four individual decoding gates are used to complete the address for reading a word.

When the read address is made in conjunction with the read-enable signal, the word appears at the four outputs.

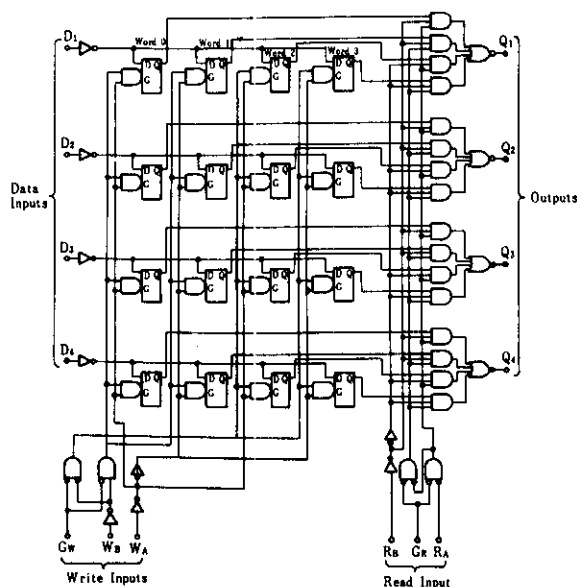
## PIN ARRANGEMENT



## FUNCTION TABLE

Write Inputs			Word			
$W_B$	$W_A$	$G_W$	0	1	2	3
L	L	L	$Q = D$	$Q_0$	$Q_0$	$Q_0$
L	H	L	$Q_0$	$Q = D$	$Q_0$	$Q_0$
H	L	L	$Q_0$	$Q_0$	$Q = D$	$Q_0$
H	H	L	$Q_0$	$Q_0$	$Q_0$	$Q = D$
X	X	H	$Q_0$	$Q_0$	$Q_0$	$Q_0$

## BLOCK DIAGRAM



Read Inputs			Outputs			
$R_B$	$R_A$	$G_R$	$Q_1$	$Q_2$	$Q_3$	$Q_4$
L	L	L	$W_0 B_1$	$W_0 B_2$	$W_0 B_3$	$W_0 B_4$
L	H	L	$W_1 B_1$	$W_1 B_2$	$W_1 B_3$	$W_1 B_4$
H	L	L	$W_2 B_1$	$W_2 B_2$	$W_2 B_3$	$W_2 B_4$
H	H	L	$W_3 B_1$	$W_3 B_2$	$W_3 B_3$	$W_3 B_4$
X	X	H	Z	Z	Z	Z

Notes: H = high level, L = low level, X = irrelevant, Z = high impedance (off)  
 $(Q=D)$  = The four selected internal flip-flop outputs will assume the states applied to the four external data inputs.  
 $Q_0$  = The level of Q before the indicated input conditions were established.  
 $W_0 B_1$  = The first bit of word 0, etc.

## RECOMMENDED OPERATING CONDITIONS

Item	Symbol	min	typ	max	Unit
Supply voltage	$V_{CC}$	4.75	5.00	5.25	V
Output current	$I_{OH}$	—	—	-2.6	mA
	$I_{OL}$	—	—	8	mA
Pulse width	Read enable	$t_w$	25	—	ns
	Write enable		60	—	
Setup time	Data	$t_{su}$	10	—	ns
	Write enable		15	—	
Hold time	Data	$t_h$	15	—	ns
	Write enable		5	—	
Latch time	$t_{LATCH}$	60	—	—	ns

## ELECTRICAL CHARACTERISTICS ( $T_a = -20 \sim +75^\circ\text{C}$ )

Item	Symbol	Test Conditions	min	typ*	max	Unit
Input voltage	$V_{IH}$		2.0	—	—	V
	$V_{IL}$		—	—	0.8	V
Output voltage	$V_{OH}$	$V_{CC}=4.75\text{V}$ , $V_{IH}=2\text{V}$ , $V_{IL}=0.8\text{V}$ , $I_{OH}=-2.6\text{mA}$	2.4	—	—	V
	$V_{OL}$	$V_{CC}=4.75\text{V}$ , $V_{IH}=2\text{V}$ , $V_{IL}=0.8\text{V}$ , $I_{OL}=4\text{mA}$	—	—	0.4	V
		$I_{OL}=8\text{mA}$	—	—	0.5	
Off-state output current	$I_{OZH}$	$V_{CC}=5.25\text{V}$ , $V_{IH}=2\text{V}$	$V_O=2.7\text{V}$	—	20	$\mu\text{A}$
	$I_{OZL}$		$V_O=0.4\text{V}$	—	-20	
Input current	$I_{IH}$	$V_{CC}=5.25\text{V}$ , $V_I=2.7\text{V}$	Any D, R or W	—	20	$\mu\text{A}$
			$G_W$	—	40	
			$G_R$	—	60	
	$I_{IL}$	$V_{CC}=5.25\text{V}$ , $V_I=0.4\text{V}$	Any D, R or W	—	-0.4	mA
			$G_W$	—	-0.8	
			$G_R$	—	-1.2	
	$I_I$	$V_{CC}=5.25\text{V}$ , $V_I=7\text{V}$	Any D, R or W	—	0.1	mA
			$G_W$	—	0.2	
			$G_R$	—	0.3	
Short-circuit output current	$I_{OS}$	$V_{CC}=5.25\text{V}$	-30	—	-130	mA
Supply current	$I_{CC}^{**}$	$V_{CC}=5.25\text{V}$	—	30	50	mA
Input clamp voltage	$V_{IK}$	$V_{CC}=4.75\text{V}$ , $I_{IN}=-18\text{mA}$	—	—	-1.5	V

\*  $V_{CC}=5\text{V}$ ,  $T_a=25^\circ\text{C}$

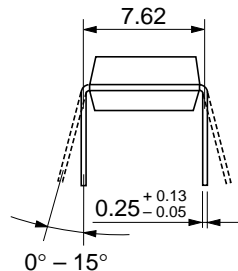
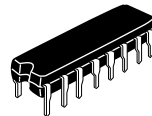
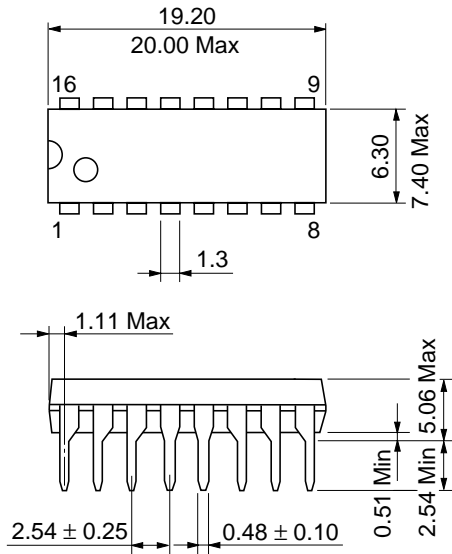
\*\* : Maximum  $I_{CC}$  is guaranteed for the following worst case conditions: 4.5V is applied to all data inputs and both enable inputs, all address inputs are grounded and all outputs are open.

## SWITCHING CHARACTERISTICS ( $V_{CC}=5\text{V}$ , $T_a=25^\circ\text{C}$ )

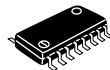
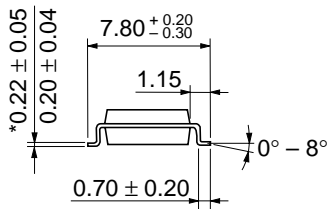
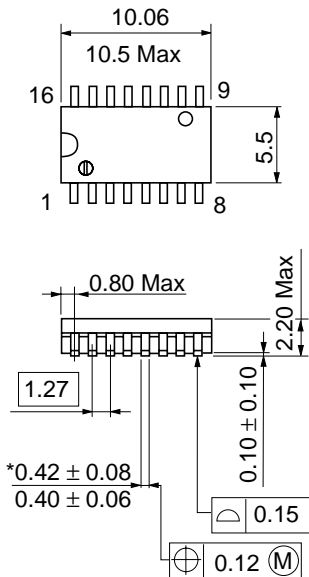
Item	Symbol	Inputs	Outputs	Test Conditions	min	typ	max	Unit
Propagation delay time	$t_{PLH}$	Read	$Q_1 \sim Q_4$	$C_L = 15\text{pF}$ , $R_L = 2\text{k}\Omega$	—	23	40	ns
	$t_{PHL}$	select			—	25	45	
	$t_{PLH}$	Write	$Q_1 \sim Q_4$		—	26	45	
	$t_{PHL}$	enable			—	28	50	
	$t_{PLH}$	Data	$Q_1 \sim Q_4$		—	25	45	
	$t_{PHL}$				—	23	40	
Output enable time	$t_{ZH}$	Read	$Q_1 \sim Q_4$	—	15	35		
	$t_{ZL}$			—	22	40		
Output disable time	$t_{HZ}$	enable		$C_L = 5\text{pF}$ , $R_L = 2\text{k}\Omega$	—	30	50	
	$t_{LZ}$			—	16	35		



Unit: mm

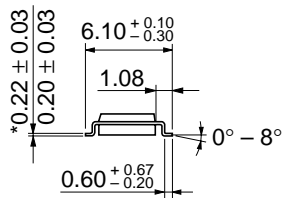
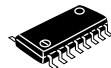
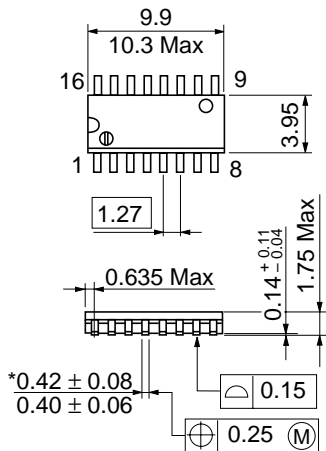


Hitachi Code	DP-16
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	1.07 g



\*Dimension including the plating thickness  
Base material dimension

Hitachi Code	FP-16DA
JEDEC	—
EIAJ	Conforms
Weight (reference value)	0.24 g



\*Dimension including the plating thickness  
Base material dimension

Hitachi Code	FP-16DN
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	0.15 g



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# HITACHI

## Hitachi, Ltd.

Semiconductor & Integrated Circuits.  
Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan  
Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

URL	NorthAmerica	: <a href="http://semiconductor.hitachi.com/">http://semiconductor.hitachi.com/</a>
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## For further information write to:

Hitachi Semiconductor (America) Inc. 179 East Tasman Drive, San Jose, CA 95134 Tel: <1> (408) 433-1990 Fax: <1> (408) 433-0223	Hitachi Europe GmbH Electronic components Group Dornacher StraÙe 3 D-85622 Feldkirchen, Munich Germany Tel: <49> (89) 9 9180-0 Fax: <49> (89) 9 29 30 00  Hitachi Europe Ltd. Electronic Components Group. Whitebrook Park Lower Cookham Road Maidenhead Berkshire SL6 8YA, United Kingdom Tel: <44> (1628) 585000 Fax: <44> (1628) 778322
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Hitachi Asia Pte. Ltd.  
16 Collyer Quay #20-00  
Hitachi Tower  
Singapore 049318  
Tel: 535-2100  
Fax: 535-1533

Hitachi Asia Ltd.  
Taipei Branch Office  
3F, Hung Kuo Building, No.167,  
Tun-Hwa North Road, Taipei (105)  
Tel: <886> (2) 2718-3666  
Fax: <886> (2) 2718-8180

Hitachi Asia (Hong Kong) Ltd.  
Group III (Electronic Components)  
7/F., North Tower, World Finance Centre,  
Harbour City, Canton Road, Tsim Sha Tsui,  
Kowloon, Hong Kong  
Tel: <852> (2) 735 9218  
Fax: <852> (2) 730 0281  
Telex: 40815 HITEC HX

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